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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,242	BAILEY ET AL.	
Examiner	Art Unit	
Linh V. Nguyen	2819	

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Class	Subclass	Date	Examiner
330	253,252 254,257 263,269	5/5/2005	LN
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differential, pair, transitor, feed back, current source, induct, output, first and second, vairable capcitor	5/5/2005	LN
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